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Understanding [Embedded - CPLDs \(Complex Programmable Logic Devices\)](#)

Embedded - CPLDs, or Complex Programmable Logic Devices, are highly versatile digital logic devices used in electronic systems. These programmable components are designed to perform complex logical operations and can be customized for specific applications. Unlike fixed-function ICs, CPLDs offer the flexibility to reprogram their configuration, making them an ideal choice for various embedded systems. They consist of a set of logic gates and programmable interconnects, allowing designers to implement complex logic circuits without needing custom hardware.

Applications of Embedded - CPLDs

Details

Product Status	Obsolete
Programmable Type	In System Programmable
Delay Time tpd(1) Max	10 ns
Voltage Supply - Internal	4.5V ~ 5.5V
Number of Logic Elements/Blocks	-
Number of Macrocells	128
Number of Gates	-
Number of I/O	68
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	100-BQFP
Supplier Device Package	100-PQFP (14x20)
Purchase URL	https://www.e-xfl.com/product-detail/lattice-semiconductor/m5-128-68-10yi-1



Table 1. MACH 5 Device Features ¹

Feature	M5-128/1 M5LV-128		M5-192/1	M5-256/1 M5LV-256		M5-320 M5LV-320		M5-384 M5LV-384		M5-512 M5LV-512	
Supply Voltage (V)	5	3.3	5	5	3.3	5	3.3	5	3.3	5	3.3
Macrocells	128	128	192	256	256	320	320	384	384	512	512
Maximum User I/O Pins	120	120	120	160	160	192	160	160	160	256	256
t _{PD} (ns)	5.5	5.5	5.5	5.5	5.5	6.5	6.5	6.5	6.5	6.5	6.5
t _{SS} (ns)	3.0	3.0	3.0	3.0	3.0	3.0	3.0	3.0	3.0	3.0	3.0
t _{COS} (ns)	4.5	4.5	4.5	4.5	4.5	5.0	5.0	5.0	5.0	5.0	5.0
f _{CNT} (MHz)	182	182	182	182	182	167	167	167	167	167	167
Typical Static Power (mA)	35	35	45	55	55	70	70	75	75	100	100
IEEE 1149.1 Boundary Scan Compliant	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes
PCI-Compliant	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes

Note:

1. “M5-xxx” is for 5-V devices. “M5LV-xxx” is for 3.3-V devices.

GENERAL DESCRIPTION

The MACH[®] 5 family consists of a broad range of high-density and high-I/O Complex Programmable Logic Devices (CPLDs). The fifth-generation MACH architecture yields fast speeds at high CPLD densities, low power, and supports additional features such as in-system programmability, Boundary Scan testability, and advanced clocking options (Table 1). The MACH 5 family offers 5-V (M5-xxx) and 3.3-V (M5LV-xxx) operation.

Manufactured in state-of-the-art ISO 9000 qualified fabrication facilities on E²CMOS process technologies, MACH 5 devices are available with pin-to-pin delays as fast as 5.5 ns (Table 2). The 5.5, 6.5, 7.5, 10, and 12-ns devices are compliant with the *PCI Local Bus Specification*.

Select devices have been discontinued.
See Ordering Information section for product status.

and both the 3.3-V and the 5-V device versions are in-system programmable through an IEEE 1149.1 Test Access Port (TAP) interface.

FUNCTIONAL DESCRIPTION

The MACH 5 architecture consists of PAL blocks connected by two levels of interconnect. The **block interconnect** provides routing among 4 PAL blocks. This grouping of PAL blocks joined by the block interconnect is called a **segment**. The second level of interconnect, the **segment interconnect**, ties all of the segments together. The only logic difference between any two MACH 5 devices is the number of segments. Therefore, once a designer is familiar with one device, consistent performance can be expected across the entire family. All devices have four clock pins available which can also be used as logic inputs.



Figure 1. MACH 5 Block Diagram

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The MACH 5 PAL blocks consist of the elements listed below (Figure 2). While each PAL block resembles an independent PAL device, it has superior control and logic generation capabilities.

- ◆ I/O cells
- ◆ Product-term array and Logic Allocator
- ◆ Macrocells
- ◆ Register control generator
- ◆ Output enable generator

I/O Cells

The I/Os associated with each PAL block have a path directly back to that PAL block called **local feedback**. If the I/O is used in another PAL block, the **interconnect feeder** assigns a **block interconnect** line to that signal. The interconnect feeder acts as an input switch matrix. The block and segment interconnects provide connections between any two signals in a device. The **block feeder** assigns block interconnect lines and local feedback lines to the PAL block inputs.

Select devices have been discontinued.
See Ordering Information section for product status.

Macrocells

The macrocells for MACH 5 devices consist of a storage element which can be configured for combinatorial, registered or latched operation (Figure 3). The D-type flip-flops can be configured as T-type, J-K, or S-R operation through the use of the XOR gate associated with each macrocell.

Each PAL block has the capability to provide two input registers by using macrocells 0 and 15. In order to use this option, these macrocells must be accessed via the I/O pins associated with macrocells 3 and 12, respectively. Once the macrocell is used as an input register, it cannot be used for logic, so its clusters can be re-directed through the logic allocator to another macrocell. The

I/O pins associated with macrocells 0 and 15 can still be used as input pins. Although the I/O pins for macrocells 3 and 12 are used to connect to the input registers, these macrocells can still be used as “buried” macrocells to drive device logic via the matrix.



20446G-003

Figure 3. Macrocell Diagram

Control Generator

The control generator provides four configurable clock lines and three configurable set/reset lines to each macrocell in a PAL block. Any of the four clock lines and any of the three set/reset lines can be independently selected by any flip-flop within a block. The clock lines can be configured to provide synchronous global (pin) clocks and asynchronous product term clocks, sum term clocks, and latch enables (Figure 4). Three of the four global clocks, as well as two product-term clocks and one sum-term clock, are available per PAL block. Positive or negative edge clocking is available as well as advanced clocking features such as **complementary** and **biphase** clocking. Complementary clocking provides two clock lines exactly 180 degrees out of phase, and is useful in applications such as fast data paths. A biphase clock line clocks flip-flops on both the positive and negative edges of the clock. The configuration options for the four clock lines per PAL block are as follows:

Clock Line 0 Options

- ◆ Global clock (0, 1, 2, or 3) with positive or negative edge clock enable
- ◆ Product-term clock ($A*B*C$)
- ◆ Sum-term clock ($A+B+C$)

Clock Line 1 Options

- ◆ Global clock (0, 1, 2, or 3) with positive edge clock enable
- ◆ Global clock (0, 1, 2, or 3) with negative edge clock enable

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See Ordering Information section for product status.

- ◆ Global clock (0, 1, 2, or 3) with positive and negative edge clock enable (biphase)

Clock Line 2 Options

- ◆ Global clock (0, 1, 2, or 3) with clock enable

Clock Line 3 Options

- ◆ Complement of clock line 2 (same clock enable)
- ◆ Product-term clock (if clock line 2 does not use clock enable)



20446G-004

Figure 4. Clock Generator



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Figure 5. Set/Reset Generator

The set/reset generation portion of the control generator (Figure 5) creates three set/reset lines for the PAL block. Each macrocell can choose one of these three lines or choose no set/reset at all. All three lines can be configured for product term set/reset and two of the three lines can be configured as sum term set/reset and one of the lines can be configured as product-term or sum-term latch enable. While the set/reset signals are generated in the control generator, whether that signal sets or resets a flip-flop is determined within the individual macrocell. The same signal can set one flip-flop and reset another. PT2 or /PT2 can also be used as a latch enable for macrocells configured as latches.

**Select devices have been discontinued.
See Ordering Information section for product status.**



MULTIPLE I/O AND DENSITY OPTIONS

The MACH 5 family offers six macrocell densities in a number of I/O options. This allows designers to choose a device close to their logic density and I/O requirements, thus minimizing costs. For the same package type, every density has the same pin-out. With proper design considerations, a design can be moved to a higher or lower density part as required.

IEEE 1149.1 - COMPLIANT BOUNDARY SCAN TESTABILITY

Most MACH 5 devices have boundary scan registers and are compliant to the IEEE 1149.1 standard. This allows functional testing of the circuit board on which the device is mounted through a serial scan path that can access all critical logic nodes. Internal registers are linked internally, allowing test data to be shifted in and loaded directly onto test nodes, or test node data to be captured and shifted out for verification. In addition, these devices can be linked into a board-level serial scan path for more complete board-level testing.

IEEE 1149.1 - COMPLIANT IN-SYSTEM PROGRAMMING

Programming devices in-system provides a number of significant benefits including: rapid prototyping, lower inventory levels, higher quality, and the ability to make in-field modifications. All MACH 5 devices provide in-system programming (ISP) capability through their IEEE 1149.1-compliant Boundary Scan Test Access Port. By using the IEEE 1149.1-compliant Boundary Scan Test Access Port as the communication interface through which ISP is achieved, customers get the benefit of a standard, well-defined interface.

MACH 5 devices can be programmed across the commercial temperature and voltage range. The PC-based LatticePRO software facilitates in-system programming of MACH 5 devices. LatticePRO software takes the JEDEC file output produced by design implementation software, along with information about the Boundary Scan chain, and creates a set of vectors that are used to drive the Boundary Scan chain. LatticePRO software can use these vectors to drive a Boundary Scan chain via the parallel port of a PC. Alternatively, LatticePRO software can output files in formats understood by common automated test equipment. This equipment can then be used to program MACH 5 devices during the testing of a circuit board.

PCI COMPLIANT

MACH 5 devices in the -5/-6/-7/-10/-12 speed grades are compliant with the *PCI Local Bus Specification* version 2.1, published by the PCI Special Interest Group (SIG). The 5-V devices are fully PCI-compliant. The 3.3-V devices are mostly compliant but do not meet the PCI condition to clamp the inputs as they rise above V_{CC} because of their 5-V input tolerant feature. MACH 5 devices provide the speed, drive, density, output enables and I/Os for the most complex PCI designs.

Select devices have been discontinued.
See Ordering Information section for product status.

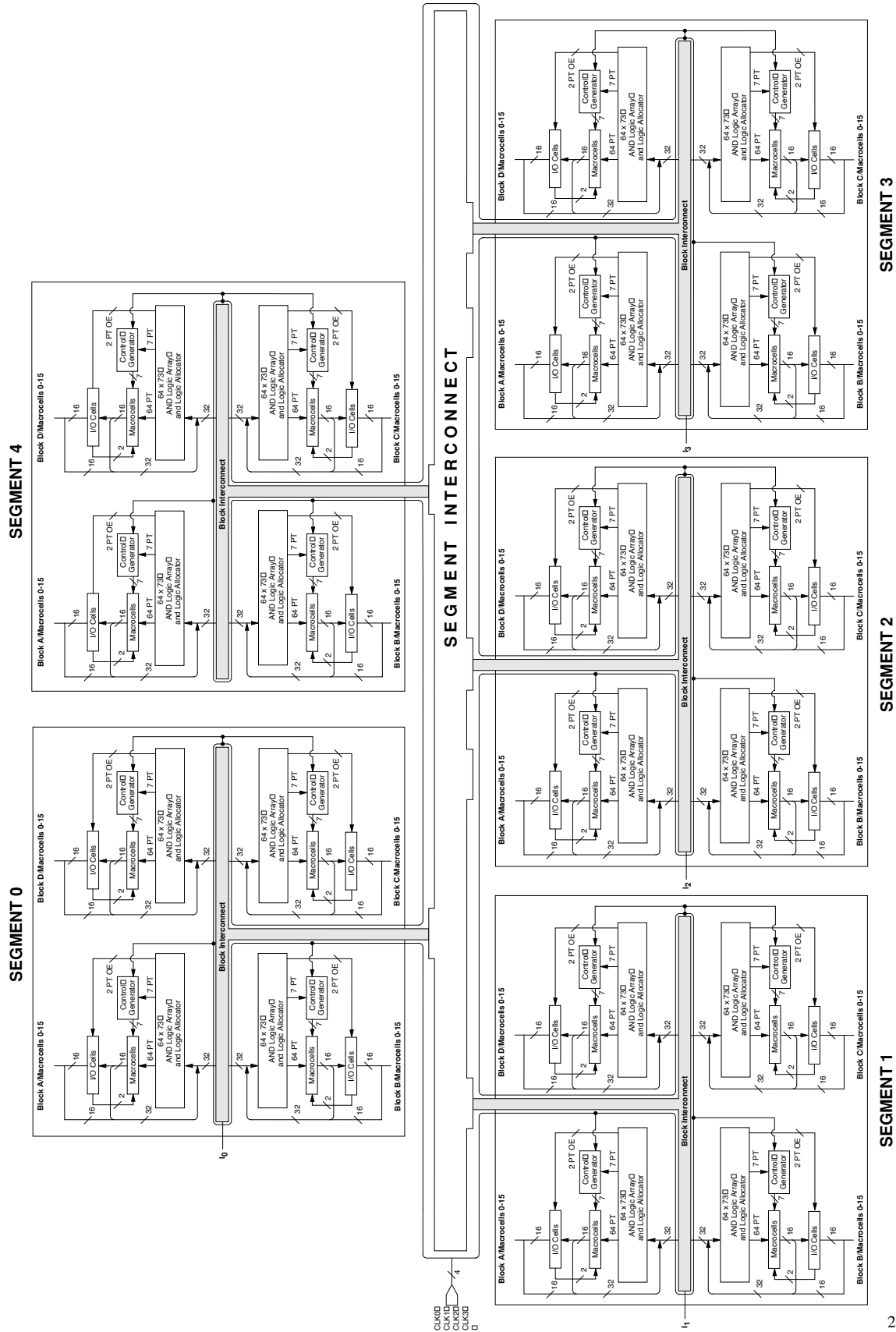


SECURITY BIT

A programmable security bit is provided on the MACH 5 devices as a deterrent to unauthorized copying of the array configuration patterns. Once programmed, this bit defeats readback of the programmed pattern by a device programmer, securing proprietary designs from competitors. Programming and verification are also defeated by the security bit. The bit can only be reset by erasing the entire device.

**Select devices have been discontinued.
See Ordering Information section for product status.**

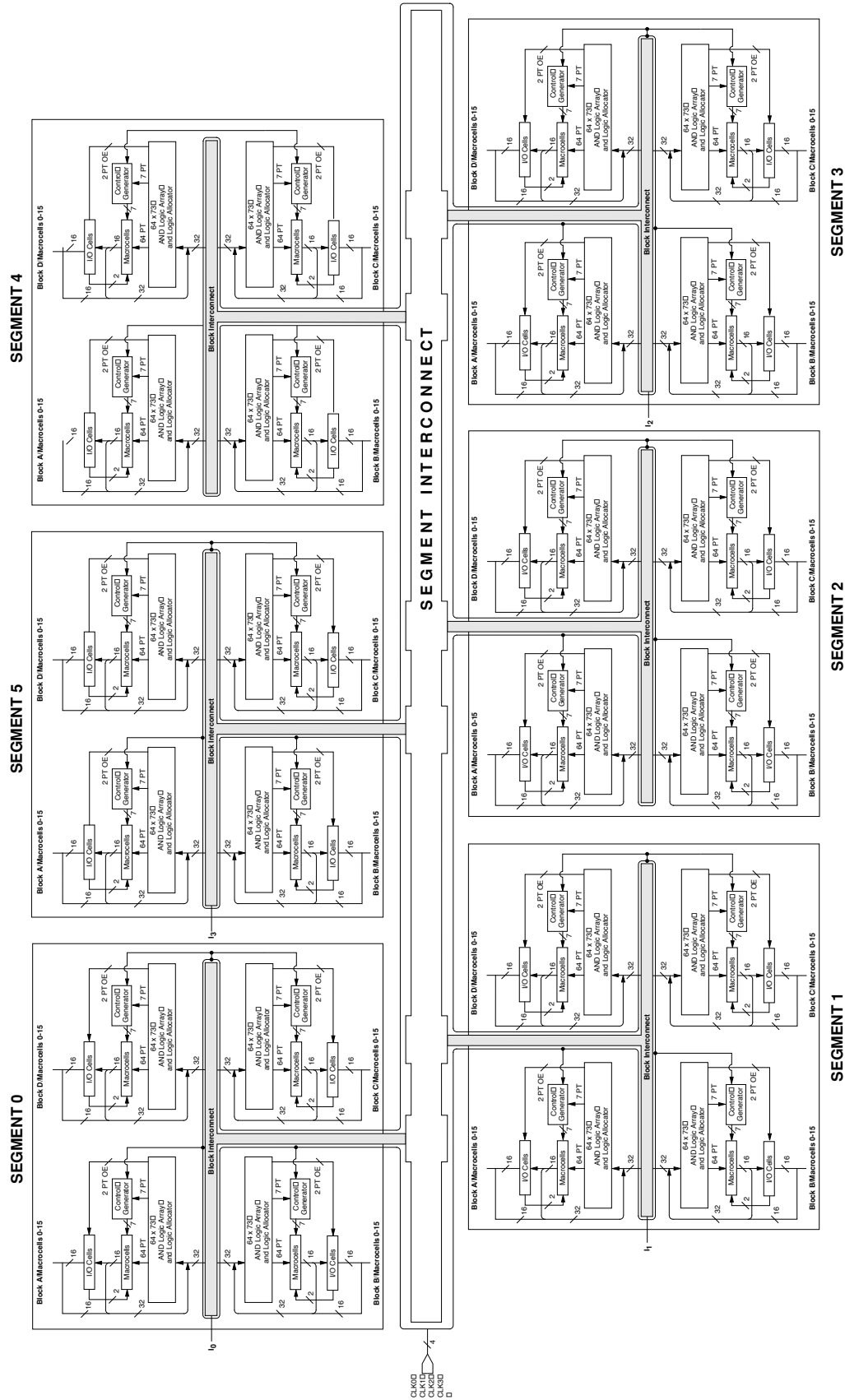
BLOCK DIAGRAM — M5(LV)-320/XXX



Select devices have been discontinued.
See Ordering Information section for product status.

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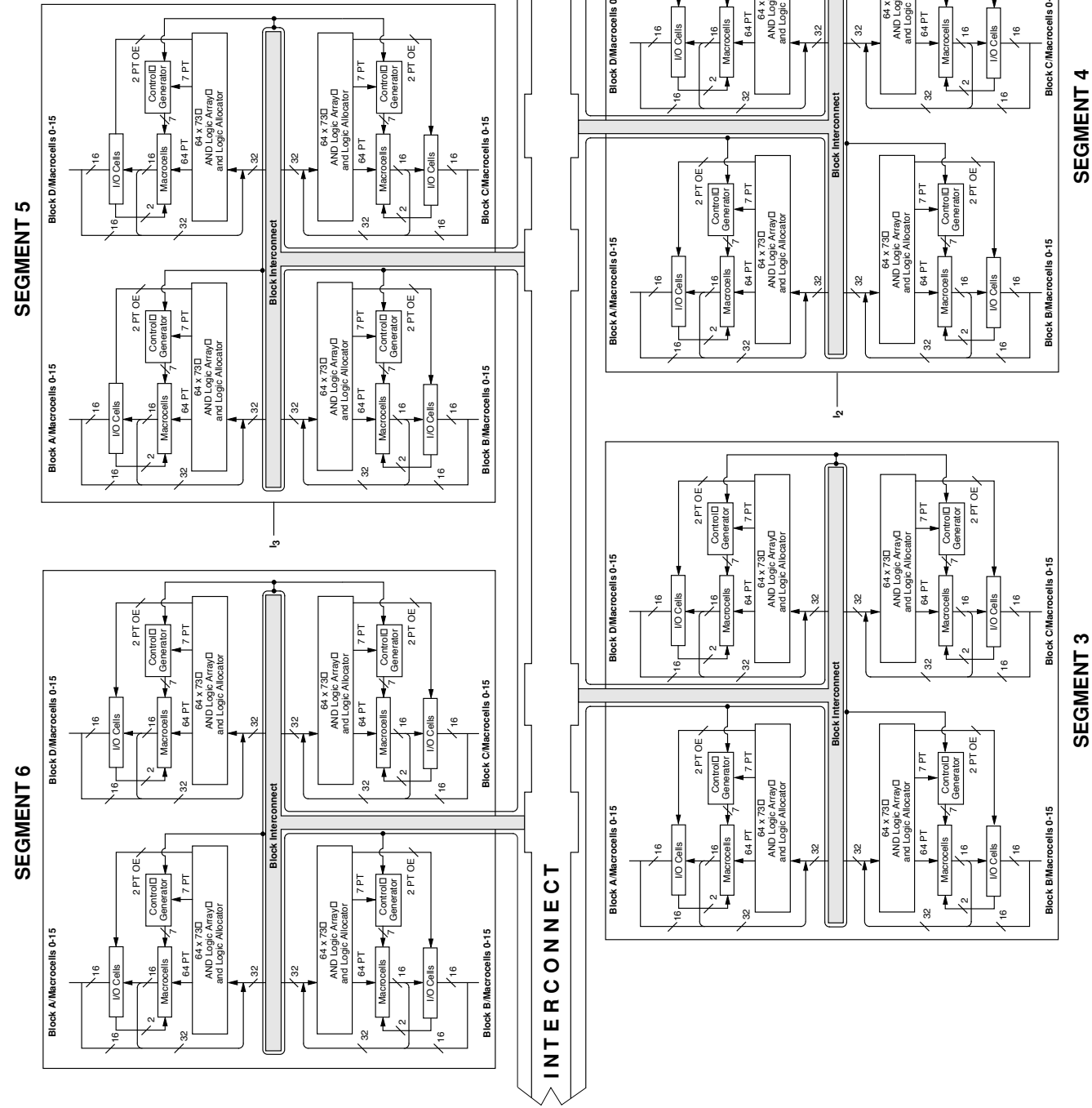
BLOCK DIAGRAM — M5(LV)-384/XXX



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Select devices have been discontinued.
See Ordering Information section for product status.

BLOCK DIAGRAM — M5(LV)-512/XXX



Continued

Select devices have been discontinued.
See Ordering Information section for product status.

20446G-013

ABSOLUTE MAXIMUM RATINGS

M5

Storage Temperature. -65°C to +150°C
 Device Junction
 Temperature (Note 1) +130°C or +150°C
 Supply Voltage
 with Respect to Ground -0.5 V to +7.0 V
 DC Input Voltage -0.5 V to 5.5 V
 Static Discharge Voltage 2000 V
 Latchup Current (-40°C to +85°C) 200 mA

Stresses above those listed under Absolute Maximum Ratings may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to Absolute Maximum Ratings for extended periods may affect device reliability.

OPERATING RANGES

Commercial (C) Devices

Ambient Temperature (T_A)
 Operating in Free Air. 0°C to +70°C
 Supply Voltage (V_{CC})
 with Respect to Ground. +4.75 V to +5.25 V

Industrial (I) Devices

Ambient Temperature (T_A)
 Operating in Free Air. -40°C to +85°C
 Supply Voltage (V_{CC})
 with Respect to Ground. +4.5 V to +5.5 V

Operating ranges define those limits between which the functionality of the device is guaranteed.

Select devices have been discontinued.
See Ordering Information section for product status.

5-V DC CHARACTERISTICS OVER OPERATING RANGES

Parameter Symbol	Parameter Description	Test Description	Min	Typ	Max	Unit
V_{OH}	Output HIGH Voltage (For M5-128/1, M5-192/1, M5-256/1, M5-320, M5-384, M5-512 Devices)	$I_{OH} = -3.2 \text{ mA}$, $V_{CC} = \text{Min}$, $V_{IN} = V_{IH} \text{ or } V_{IL}$	2.4			V
		$I_{OH} = -100 \mu\text{A}$, $V_{CC} = \text{Max}$, $V_{IN} = V_{IH} \text{ or } V_{IL}$		3.3	3.6	V
	Output HIGH Voltage (For M5-128, M5-192, M5-256 Devices)	$I_{OH} = -3.2 \text{ mA}$, $V_{CC} = \text{Min}$, $V_{IN} = V_{IH} \text{ or } V_{IL}$	2.4			V
		$I_{OH} = -2.5 \text{ mA}$, $V_{CC} = 5.25 \text{ V}$, $V_{IN} = V_{IH} \text{ or } V_{IL}$			3.6	V
V_{OL}	Output LOW Voltage (Note 2)	$I_{OL} = +16 \text{ mA}$, $V_{CC} = \text{Min}$, $V_{IN} = V_{IH} \text{ or } V_{IL}$			0.5	V
V_{IH}	Input HIGH Voltage	Guaranteed Input Logical HIGH Voltage for all Inputs (Note 3)	2.0			V
V_{IL}	Input LOW Voltage	Guaranteed Input Logical LOW Voltage for all Inputs (Note 3)			0.8	V
I_{IH}	Input HIGH Leakage Current	$V_{IN} = 5.25$, $V_{CC} = \text{Max}$ (Note 4)			10	μA
I_{IL}	Input LOW Leakage Current	$V_{IN} = 0$, $V_{CC} = \text{Max}$ (Note 4)			-10	μA
I_{OZH}	Off-State Output Leakage Current HIGH	$V_{OUT} = 5.25$, $V_{CC} = \text{Max}$, $V_{IN} = V_{IH} \text{ or } V_{IL}$ (Note 4)			10	μA
I_{OZL}	Off-State Output Leakage Current LOW	$V_{OUT} = 0$, $V_{CC} = \text{Max}$, $V_{IN} = V_{IH} \text{ or } V_{IL}$ (Note 4)			-10	μA
I_{SC}	Output Short-Circuit Current	$V_{OUT} = 0.5 V_{CC} = \text{Max}$, $V_{IN} = V_{IH} \text{ or } V_{IL}$ (Note 5)	-30		-180	mA

Note:

- 150° for M5-128, M5-192 and M5-256 devices. 130° for M5-128/1, M5-192/1, M5-256/1, M5-320, M5-384 and M5-512 devices.
- Total I_{OL} between ground pins should not exceed 64 mA.
- These are absolute values with respect to device ground, and all overshoots due to system and/or tester noise are included.
- I/O pin leakage is the worst case of I_{IL} and I_{OZL} or I_{IH} and I_{OZH} .
- Not more than one output should be shorted at a time. Duration of the short-circuit should not exceed one second.

ABSOLUTE MAXIMUM RATINGS

M5LV

Storage Temperature. -65°C to +150°C
Device Junction Temperature. +130°C
Supply Voltage
with Respect to Ground. -0.5 V to +4.5 V
DC Input Voltage. -0.5 V to 5.5 V
Static Discharge Voltage. 2000 V
Latchup Current (-40°C to +85°C). 200 mA

Stresses above those listed under Absolute Maximum Ratings may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to Absolute Maximum Ratings for extended periods may affect device reliability.

OPERATING RANGES

Commercial (C) Devices

Ambient Temperature (T_A)
Operating in Free Air. 0°C to +70°C
Supply Voltage (V_{CC})
with Respect to Ground. +3.0 V to +3.6 V

Industrial (I) Devices

Ambient Temperature (T_A)
Operating in Free Air. -40°C to +85°C
Supply Voltage (V_{CC})
with Respect to Ground. +3.0 V to +3.6 V
Operating ranges define those limits between which the functionality of the device is guaranteed.

Select devices have been discontinued.
See Ordering Information section for product status.

3.3-V DC CHARACTERISTICS OVER OPERATING RANGES

Parameter Symbol	Parameter Description	Test Description		Min	Max	Unit
V_{OH}	Output HIGH Voltage	$V_{CC} = \text{Min}$	$I_{OH} = -100 \mu A$	$V_{CC} - 0.2$		V
		$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OH} = 3.2 \text{ mA}$	2.4		V
V_{OL}	Output LOW Voltage	$V_{CC} = \text{Min}$	$I_{OL} = 100 \mu A$		0.2	V
		$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OL} = 16 \text{ mA (Note 1)}$		0.5	V
V_{IH}	Input HIGH Voltage	$V_{OUT} \geq V_{OH} \text{ Min or } V_{OUT} \leq V_{OL} \text{ Max (Note 2)}$		2.0	5.5	V
V_{IL}	Input LOW Voltage	$V_{OUT} \geq V_{OH} \text{ Min or } V_{OUT} \leq V_{OL} \text{ Max (Note 2)}$		-0.3	0.8	V
I_{IH}	Input HIGH Leakage Current	$V_{IN} = 3.6, V_{CC} = \text{Max (Note 3)}$			10	μA
I_{IL}	Input LOW Leakage Current	$V_{IN} = 0, V_{CC} = \text{Max (Note 3)}$			-10	μA
I_{OZH}	Off-State Output Leakage Current HIGH	$V_{OUT} = 3.6, V_{CC} = \text{Max}, V_{IN} = V_{IH} \text{ or } V_{IL} \text{ (Note 3)}$			10	μA
I_{OZL}	Off-State Output Leakage Current LOW	$V_{OUT} = 0, V_{CC} = \text{Max}, V_{IN} = V_{IH} \text{ or } V_{IL} \text{ (Note 3)}$			-10	μA
I_{SC}	Output Short-Circuit Current	$V_{OUT} = 0.5 V_{CC} = \text{Max}, V_{IN} = V_{IH} \text{ or } V_{IL} \text{ (Note 4)}$		-15	-160	mA

Notes:

1. Total I_{OL} between ground pins should not exceed 64 mA.
2. These are absolute values with respect to device ground, and all overshoots due to system and/or tester noise are included.
3. I/O pin leakage is the worst case of I_{IL} and I_{OZL} or I_{IH} and I_{OZH} .
4. Not more than one output should be shorted at one time. Duration of the short-circuit should not exceed one second.

M5(LV) TIMING PARAMETERS OVER OPERATING RANGES¹

		-5		-6		-7		-10		-12		-15		-20		Unit
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	
Combinatorial Delay:																
t _{PDi}	Internal combinatorial propagation delay		3.5		4.5		5.5		8.0		10.0		13.0		18.0	ns
t _{PD}	Combinatorial propagation delay		5.5		6.5		7.5		10.0		12.0		15.0		20.0	ns
Registered Delays:																
t _{SS}	Synchronous clock setup time	3.0		3.0		4.0		5.0		6.0		8.0		10.0		ns
t _{SA}	Asynchronous clock setup time	3.0		3.0		4.0		5.0		6.0		7.0		8.0		ns
t _{HS}	Synchronous clock hold time	0.0		0.0		0.0		0.0		0.0		0.0		0.0		ns
t _{HA}	Asynchronous clock hold time	3.0		3.0		4.0		5.0		6.0		7.0		8.0		ns
t _{COsi}	Synchronous clock to internal output		2.5		3.0		4.0		5.0		6.0		8.0		10.0	ns
t _{COS}	Synchronous clock to output		4.5		5.0		6.0		7.0		8.0		10.0		12.0	ns
t _{COAi}	Asynchronous clock to internal output		6.0		6.0		8.0		10.0		13.0		15.0		18.0	ns
t _{COA}	Asynchronous clock to output		8.0		8.0		10.0		12.0		15.0		17.0		20.0	ns
Latched Delays:																
t _{SAL}	Latch setup time	3.0		4.0		4.0		5.0		6.0		7.0		8.0		ns
t _{HAL}	Latch hold time	3.0		3.0		4.0		5.0		6.0		7.0		8.0		ns
t _{PDLi}	Transparent latch internal		6.0		7.0		7.0		8.0		9.0		10.0		10.0	ns
t _{PDL}	Propagation delay through transparent latch		8.0		9.0		9.0		10.0		11.0		12.0		12.0	ns
t _{GOAi}	Gate to internal output		7.0		8.0		8.0		9.0		10.0		11.0		12.0	ns
t _{GOA}	Gate to output		9.0		10.0		10.0		11.0		12.0		13.0		14.0	ns
Input Register Delays:																
t _{SIRS}	Input register setup time using a synchronous clock	2.0		2.0		2.0		3.0		3.0		3.0		3.0		ns
t _{SIRA}	Input register setup time using an asynchronous clock	0.0		0.0		0.0		0.0		0.0		0.0		0.0		ns
t _{HIRS}	Input register hold time using a synchronous clock	3.0		3.0		3.0		4.0		4.0		4.0		4.0		ns
t _{HIRA}	Input register hold time using an asynchronous clock	6.0		6.0		6.0		7.0		7.0		7.0		7.0		ns
Input Latch Delays:																
t _{SIL}	Input latch setup time	2.0		2.0		2.0		3.0		3.0		3.0		3.0		ns
t _{HIL}	Input latch hold time	6.0		6.0		6.0		7.0		7.0		7.0		7.0		ns
t _{PDILi}	Transparent input latch		5.0		5.0		5.5		6.0		6.0		6.0		6.0	ns
Output Delays:																
t _{BUF}	Output buffer delay		2.0		2.0		2.0		2.0		2.0		2.0		2.0	ns
t _{SLW}	Slow slew rate delay		2.5		2.5		2.5		2.5		2.5		2.5		2.5	ns
t _{EA}	Output enable time		7.5		7.5		9.5		10.0		12.0		15.0		20.0	ns
t _{ER}	Output disable time		7.5		7.5		9.5		10.0		12.0		15.0		20.0	ns

Select devices have been discontinued.
See Ordering Information section for product status.

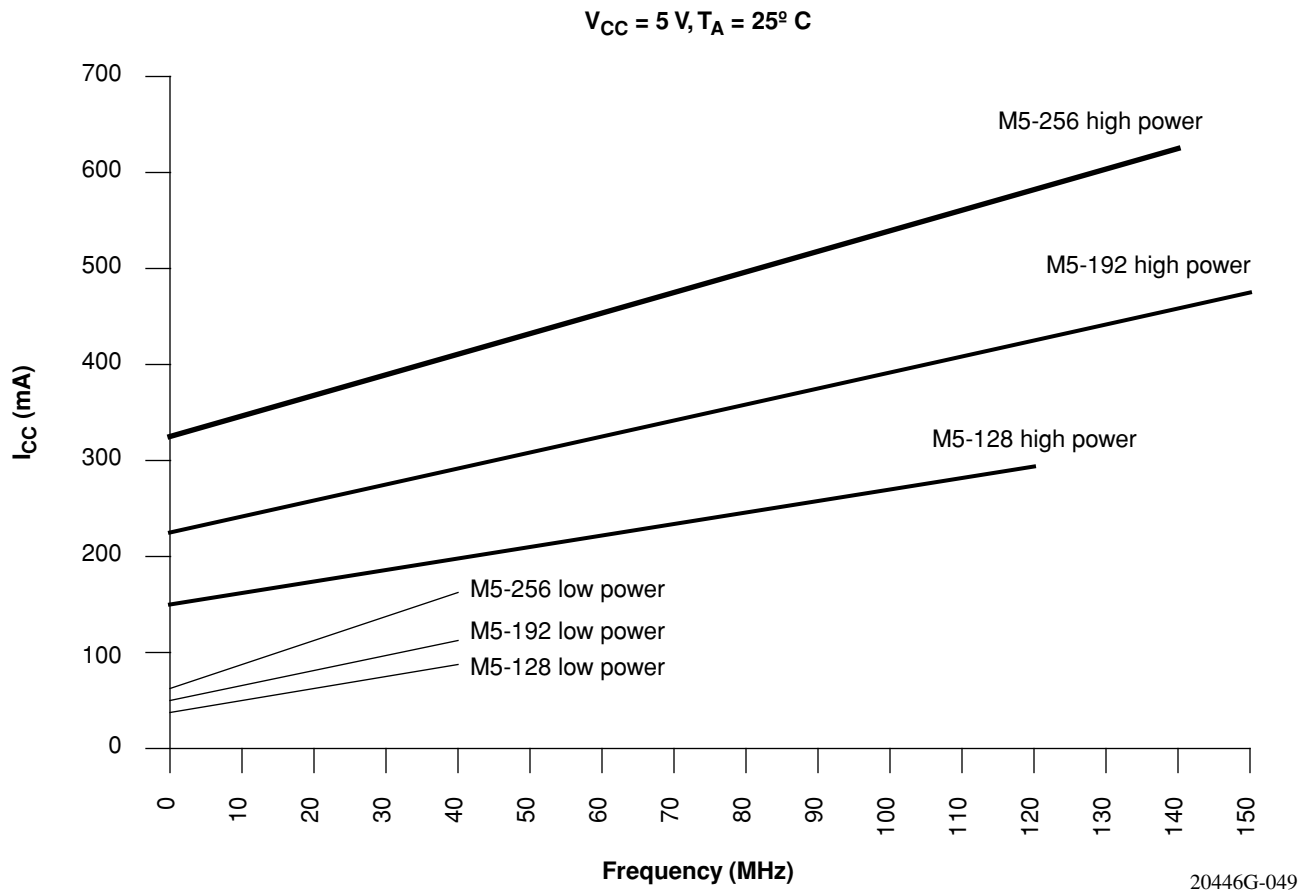


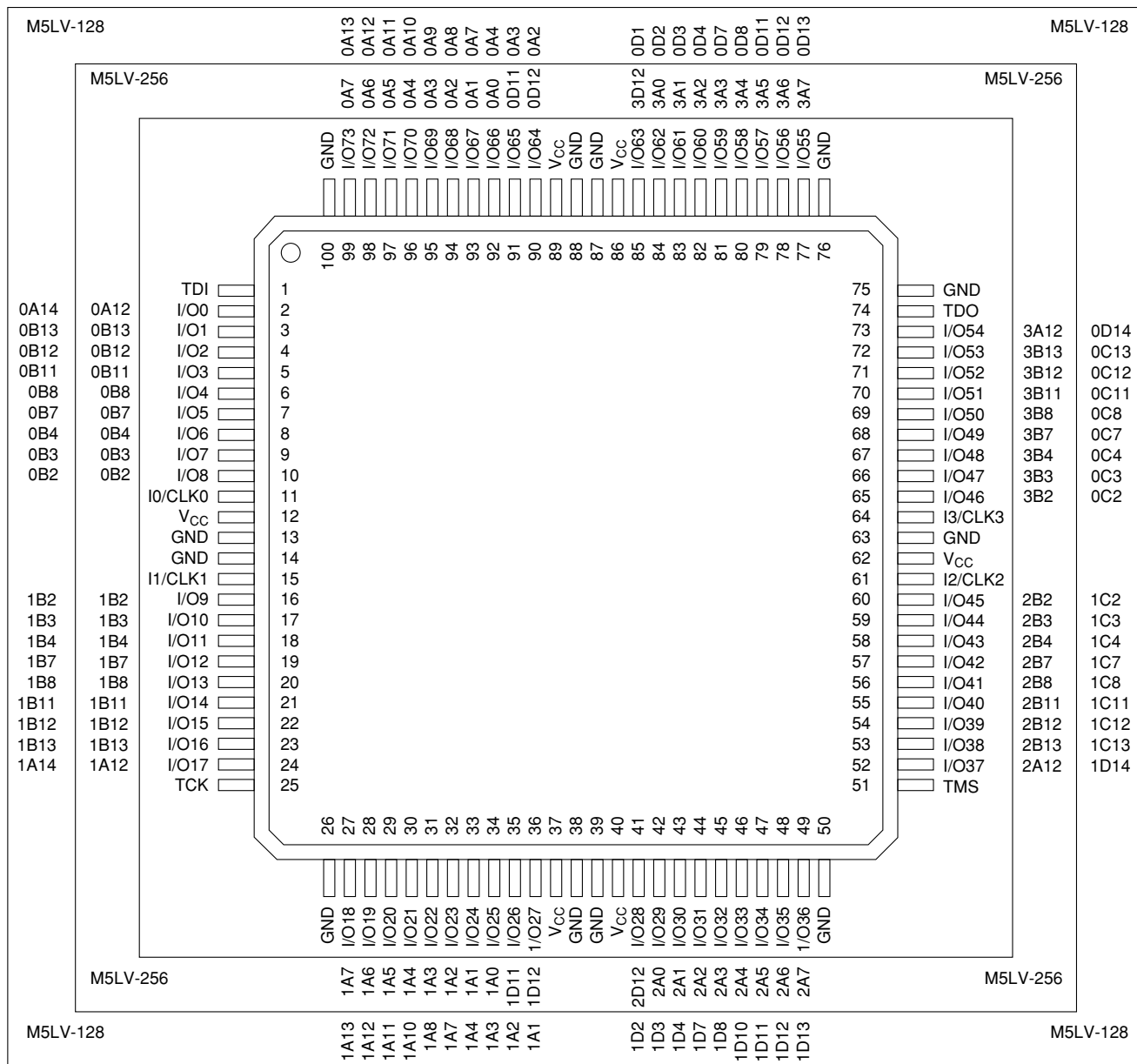
Figure 9. I_{CC} Curves at High/Low Power Modes

Select devices have been discontinued.
See Ordering Information section for product status.

100-PIN TQFP CONNECTION DIAGRAM – 74 I/O

Top View

100-Pin TQFP (74 I/O)



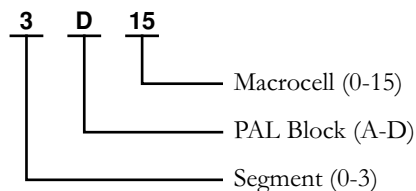
Select devices have been discontinued.
See Ordering Information section for product status.

20446G-018

Pin Designations

CLK = Clock
GND = Ground
I = Input
I/O = Input/Output
NC = No Connect

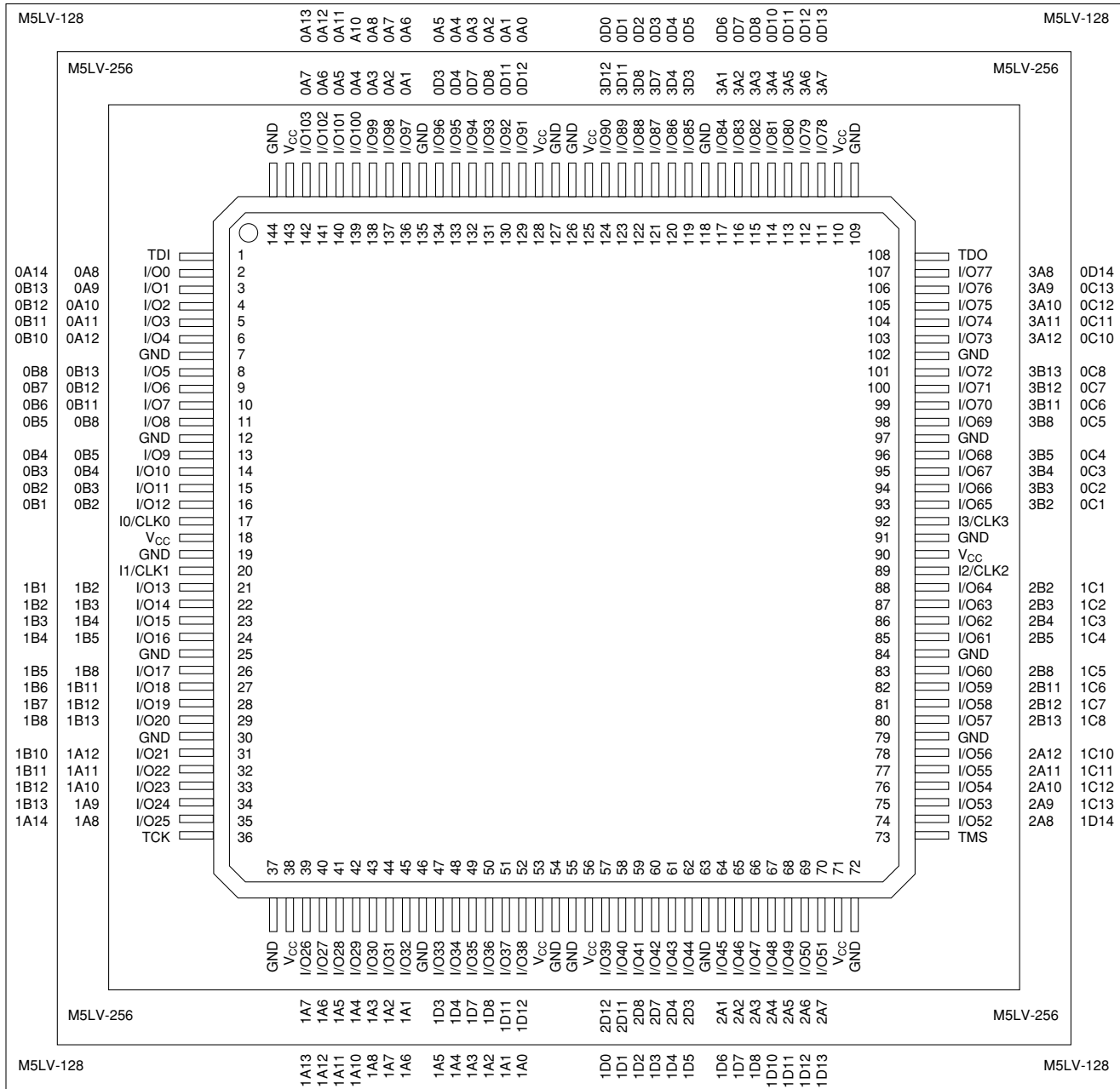
V_{CC} = Supply Voltage
TDI = Test Data In
TCK = Test Clock
TMS = Test Mode Select
TDO = Test Data Out



144-PIN TQFP CONNECTION DIAGRAM

Top View

144-Pin TQFP



Select devices have been discontinued.
See Ordering Information section for product status.

20446G-020

208-PIN PQFP (WITH INTERNAL HEAT SPREADER) CONNECTION DIAGRAM Top View

208-Pin PQFP (320, 384, 512 Macrocells)



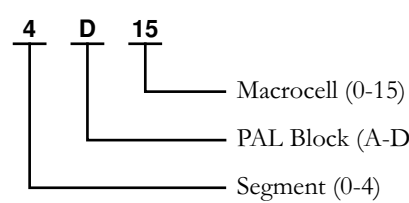
Select devices have been discontinued.
See Ordering Information section for product status.

20446G-024

256-BALL BGA CONNECTION DIAGRAM — M5-320

Bottom View (Macrocell Association)

256-Ball BGA

	A	B	C	D	E	F	G	H	J	K	L	M	N	P	R	T	U	V	W	Y		
1	GND	GND	3A11	3D15	3D12	GND	3D7	GND	3D3	3D2	GND	2D2	GND	2D7	GND	2D10	2D13	2D15	GND	GND	1	
2	GND	3B2	3A3	3A8	3A13	3D13	3D9	3D8	3D4	3D3	I3/CLK3	2D3	2D4	2D8	2D12	2A15	2A13	2A12	2A9	2A7	2	
3	GND	3B8	V _{CC}	3A2	3A4	3A12	3D14	3D10	3D5	3D0	2D0	2D5	2D9	2D14	2A14	2A10	2A8	V _{CC}	2A3	GND	3	
4	3B13	3B11	3B3	V _{CC}	TDO	3A7	V _{CC}	3D11	3D6	3D1	2D1	2D6	2D11	V _{CC}	2A11	TMS	V _{CC}	2A6	2A2	2A0	4	
5	4B14	4B15	3B4	V _{CC}	Pin Designations CLK = Clock GND = Ground I = Input I/O = Input/Output NC = No Connect V_{CC} = Supply Voltage TDI = Test Data In TCK = Test Clock TMS = Test Mode Select TDO = Test Data Out  <td>V_{CC}</td> <td>2A4</td> <td>2A1</td> <td>2B0</td> <td>2B1</td> <td>5</td>												V _{CC}	2A4	2A1	2B0	2B1	5
6	GND	4B11	3B12	3B7													V _{CC}	2A1	2B4	GND	6	
7	4B8	4B10	4B13	V _{CC}													V _{CC}	2B2	2B5	2B7	7	
8	4B4	4B6	4B9	4B12													2B3	2B6	2B9	2B11	8	
9	GND	4B3	4B5	4B7													2B8	2B10	2B12	GND	9	
10	GND	4B0	4B1	4B2													2B13	2B14	2B15	GND	10	
11	GND	4A0	4A1	4A2													1B13	1B14	1B15	GND	11	
12	GND	4A3	4A5	4A7													1B8	1B10	1B12	GND	12	
13	4A4	4A6	4A9	4A12													1B3	1B6	1B9	1B11	13	
14	4A8	4A10	4A13	V _{CC}													V _{CC}	1B2	1B5	1B7	14	
15	GND	4A11	0B12	0B7													1A4	1A1	1B4	GND	15	
16	4A14	4A15	0B4	V _{CC}													V _{CC}	1A5	1B0	1B1	16	
17	0B13	0B11	0B3	V _{CC}	TDI	0A7	V _{CC}	0D11	0D6	0D1	1D1	1D6	1D11	V _{CC}	1A11	TCK	V _{CC}	1A6	1A2	1A0	17	
18	GND	0B8	V _{CC}	0A2	0A4	0A12	0D14	0D9	0D5	0D0	1D0	1D5	1D10	1D14	1A14	1A10	1A8	V _{CC}	1A3	GND	18	
19	0B2	0A3	0A8	0A11	0A13	0D12	0D8	0D4	0D3	I0/CLK0	I1/CLK1	1D4	1D8	1D9	1D13	1A15	1A12	1A9	1A7	GND	19	
20	GND	GND	0D15	0D13	0D10	GND	0D7	GND	0D2	GND	1D2	1D3	GND	1D7	GND	1D12	1D15	1A13	GND	GND	20	

Select devices have been discontinued.
See Ordering Information section for product status.

352-BALL BGA CONNECTION DIAGRAM — M5-512, M5LV-512

Bottom View (I/O Pin-outs)

352-Ball BGA

	A	B	C	D	E	F	G	H	J	K	L	M	N	P	R	T	U	V	W	Y	AA	AB	AC	AD	AE	AF				
1	NC	NC	NC	GND	NC	I/O189	I/O183	I/O176	I/O177	I/O178	I/O162	I/O156	I/O150	I/O143	I/O136	I/O129	I/O128	I/O134	I/O142	GND	GND	NC	I/O188	I/O184	I/O185	I/O186	I/O187	I/O182	NC	
2	NC	NC	NC	I/O224	I/O225	I/O190	I/O176	I/O169	I/O170	I/O171	I/O162	I/O156	I/O150	I/O143	I/O136	I/O129	I/O128	I/O134	I/O142	GND	GND	NC	I/O188	I/O184	I/O185	I/O186	I/O187	I/O182	NC	
3	NC	NC	NC	I/O205	I/O206	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
4	NC	NC	NC	TDO	I/O205	I/O189	I/O206	I/O207	I/O208	I/O209	I/O210	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
5	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
6	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
7	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
8	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
9	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
10	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
11	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
12	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
13	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
14	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
15	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
16	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
17	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
18	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
19	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
20	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
21	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
22	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
23	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
24	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
25	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251
26	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	I/O190	I/O207	I/O208	I/O209	I/O210	I/O211	I/O194	I/O213	I/O232	I/O249	I/O195	I/O214	I/O233	I/O234	I/O235	I/O250	I/O196	I/O215	I/O216	I/O237	I/O252	I/O251	I/O236	I/O252	I/O251

Pin Designations

CLK = Clock

GND = Ground

I = Input

I/O = Input/Output

NC = No Connect

V_{CC} = Supply Voltage

TDI = Test Data In

TCK = Test Clock

TMS = Test Mode Select

TDO = Test Data Out

20446G-030

Pin Designations

- CLK = Clock
- GND = Ground
- I = Input
- I/O = Input/Output
- NC = No Connect
- V_{CC} = Supply Voltage
- TDI = Test Data In
- TCK = Test Clock
- TMS = Test Mode Select
- TDO = Test Data Out

20446G-030

Select devices have been discontinued.
See Ordering Information section for product status.

352-BALL BGA CONNECTION DIAGRAM — M5-512, M5LV-512

Bottom View (Macrocell Association)

352-Ball BGA

	A	B	C	D	E	F	G	H	J	K	L	M	N	P	R	T	U	V	W	Y	AA	AB	AC	AD	AE	AF	
1	NC	NC	NC	GND	5A0	5A3	5A6	V _{CC}	5A11	V _{CC}	5D12	5D7	5D2	V _{CC}	4D3	4D8	4D12	V _{CC}	4A11	V _{CC}	4A4	4A0	V _{CC}	3A14	3A15	3A13	3A12
2	NC	NC	NC	5A2	5A5	5A9	5A14	5A15	5D13	5D10	5D8	5D4	5D1	4D0	4D2	4D6	4D10	4D13	4A15	4A12	4A9	4A8	4A3	4A1	GND	NC	NC
3	GND	GND	NC	5A1	5A4	5A7	5A8	5A10	5A13	5D14	5D9	5D5	5D1	I ₂ /CLK ₂	4D4	4D7	4D11	4D14	4A14	4A10	4A7	4A5	4A2	TMS	NC	NC	NC
4	NC	6A14	NC	TDO	5A0	5A3	5A6	V _{CC}	5A11	V _{CC}	5D12	5D7	5D2	V _{CC}	4D3	4D8	4D12	V _{CC}	4A11	V _{CC}	4A4	4A0	V _{CC}	3A14	3A15	3A13	3A12
5	GND	6A12	6A13	V _{CC}	Pin Designations CLK = Clock GND = Ground I = Input I/O = Input/Output NC = No Connect V_{CC} = Supply Voltage TDI = Test Data In TCK = Test Clock TMS = Test Mode Select TDO = Test Data Out																						
6	NC	6A9	6A10	6A15																				3A10	3A8	3A7	3A5
7	GND	6A6	6A8	6A11																				3A6	3A4	3A3	3A0
8	6A1	6A4	6A5	6A7																				3A2	3A1	3B0	NC
9	6B1	6A0	6A2	6A3																				V _{CC}	3B1	3B2	GND
10	GND	6B2	6B0	V _{CC}																				3B3	3B4	3B5	3B6
11	6B6	6B5	6B4	6B3																				3B7	3B8	3B9	3B10
12	6B10	6B9	6B8	6B7																				3B11	3B12	3B13	3B14
13	6B14	6B13	6B12	6B11																				V _{CC}	2B15	3B15	GND
14	GND	7B15	6B15	V _{CC}																				2B11	2B12	2B13	2B14
15	7B14	7B13	7B12	7B11																			2B7	2B8	2B9	2B10	
16	NC	7B10	7B9	7B8																			2B3	2B4	2B5	2B6	
17	7B7	7B6	7B5	7B4																			V _{CC}	2B0	2B2	GND	
18	GND	7B3	7B2	V _{CC}																			2A3	2A2	2A0	2B1	
19	7B1	7B0	7A1	7A4																			2A7	2A5	2A4	2A1	
20	7A0	7A2	7A3	7A8																			2A11	2A8	2A6	GND	
21	7A5	7A6	7A7	7A12																			2A15	2A10	2A9	NC	
22	GND	7A9	7A11	7A15																			V _{CC}	2A13	2A12	GND	
23	7A10	7A13	7A14	V _{CC}																			TCK	NC	2A14	NC	
24	NC	NC	TDI	0A2	0A5	0A7	0A10	0A11	0D14	0D11	0D7	0D4	I ₀ /CLK ₀	1D1	1D5	1D9	1D14	1A13	1A10	1A8	1A7	1A4	1A1	NC	GND	GND	
25	GND	GND	0A1	0A3	0A8	0A9	0A12	0A15	0D13	0D10	0D6	0D2	0D0	1D0	1D4	1D8	1D10	1D13	1A15	1A14	1A9	1A5	1A2	NC	NC	NC	NC
26	NC	NC	GND	0A6	NC	GND	0A13	0D15	GND	0D9	0D5	0D1	GND	I ₁ /CLK ₁	1D3	1D6	GND	1D11	1D15	GND	1A12	NC	GND	NC	NC	NC	NC

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D

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Macrocell (0-15)

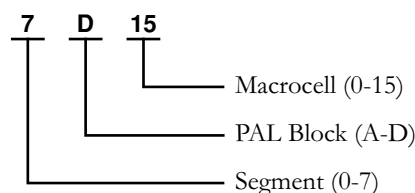
PAL Block (A-D)

Segment (0-7)

20446G-031

Pin Designations

- CLK = Clock
- GND = Ground
- I = Input
- I/O = Input/Output
- NC = No Connect
- V_{CC} = Supply Voltage
- TDI = Test Data In
- TCK = Test Clock
- TMS = Test Mode Select
- TDO = Test Data Out



20446G-031

Select devices have been discontinued.
See Ordering Information section for product status.